

Application/Control No.	Applicant(s)/Patent under Reexamination LEE, SUNG-DAE	
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Examiner	Art Unit	
Kieu D. Vu	2173	

SEARCHED				
Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East search (USPAT USPGPUB EPO JPO DERWENT IBM_TDB USOCR) (See Search History Printout)	7/26/2007	ΚV		
(See Search History Printout) update search	118/08	ΚV		